



# FCC PART 15, CLASS B

## TEST REPORT

For

### Complex International Limited

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**FCC ID: 2ABGBJVX57**

<b>Report Type:</b> Original Report	<b>Product Type:</b> 2G Feature Phone
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<b>Report Number:</b> <u>RSZ150114003-00A</u>	
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**Note:** This test report is prepared for the customer shown above and for the device described herein. It may not be duplicated or used in part without prior written consent from Bay Area Compliance Laboratories Corp.

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## GENERAL INFORMATION

### Product Description for Equipment under Test (EUT)

The *Complex International Limited*'s product, model number: *JV X57*(FCC ID:2ABGBJVX57) or the "EUT" in this report was a *2G Feature Phone*, which was measured approximately: 11.15 cm (L) x 4.63 cm (W) x 1.04 cm (H), rated with input voltage: DC 3.7 V rechargeable Li-ion battery or DC5.0 V from adapter, The highest operating frequency is 312MHz.

#### Adapter Information:

Model: JV X57

Input: AC100-300V, 50/60Hz, 150mA

Output: DC 5.0V, 600mA

Note: the product, series model *JV X57* and *JFP 75* are electrically identical, the differences among them are their model number and appearance color due to marketing purpose. Model *JV X57* was selected for fully testing, which was explained in the attached product similarity declaration letter.

*\*All measurement and test data in this report was gathered from production sample serial number: 1501195 (Assigned by Shenzhen BACL). The EUT supplied by the applicant was received on 2015-01-14*

### Objective

This test report is prepared on behalf of *Complex International Limited* in accordance with Part 2-Subpart J, Part 15-Subparts A and B of the Federal Communication Commissions rules.

The objective of the manufacturer is to determine the compliance of the EUT with FCC Part 15 B.

### Related Submittal(s)/Grant(s)

FCC Part 15.247 DSS and Part 22H/24E PCE submissions with ID: 2ABGBJVX57

### Test Facility

The test site used by Bay Area Compliance Laboratories Corp. (Shenzhen) to collect test data is located on the 6/F, the 3rd Phase of WanLi Industrial Building, ShiHua Road, FuTian Free Trade Zone Shenzhen, Guangdong, China.

Test site at Bay Area Compliance Laboratories Corp. (Shenzhen) has been fully described in reports submitted to the Federal Communication Commission (FCC). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on December 06, 2010. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2009.

The Federal Communications Commission has the reports on file and is listed under FCC Registration No.: 382179. The test site has been approved by the FCC for public use and is listed in the FCC Public Access Link (PAL) database.

## SYSTEM TEST CONFIGURATION

### Description of Test Configuration

The system was configured for testing in a manufacturer testing fashion.

EUT operation mode: Downloading (data transfer with computer)

### EUT Exercise Software

“BurnIn test v5.3” exercise software was used.

### Special Accessories

No special accessory.

### Equipment Modifications

No modification was made to the EUT tested.

### Support Equipment List and Details

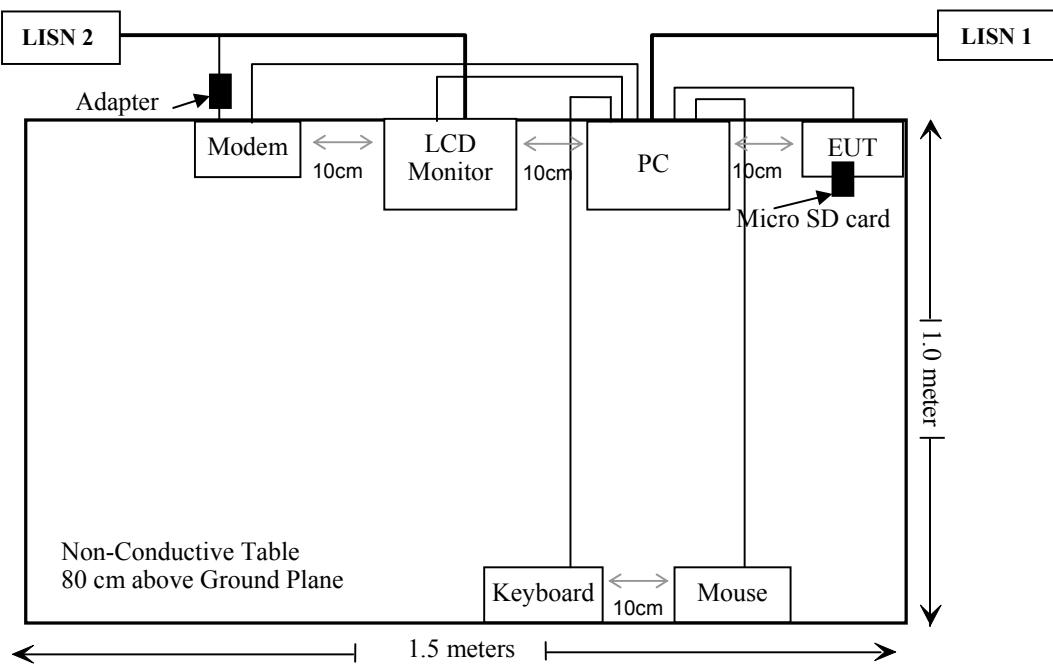
Manufacturer	Description	Model	Serial Number
DELL	PC	VOSTRO 220S	127BP2X
DELL	LCD Monitor	E178WFPC	CN-OWY564-64180-7C4-2SQH
DELL	Keyboard	L100	CNORH656658907BL05DC
DELL	Mouse	MOC5UO	G1900NKD
SAST	Modem	AEM-2100	0293
Kingston	Micro SD card	4GB	N/A

## External I/O Cable

Cable Description	Length (m)	From/Port	To
Shielding Detachable K/B Cable	1.5	Host PC	Keyboard
Shielding Detachable Mouse Cable	1.5	Host PC	Mouse
Shielding Detachable Serial Cable	1.5	Host PC	Modem
Shielding Detachable VGA Cable	1.5	Host PC	Monitor
Shielding Detachable RS232 Cable	1.0	Host PC	EUT
Un-shielding Detachable USB Cable	1.1	EUT	PC

## Block Diagram of Test Setup

For conducted emission



## SUMMARY OF TEST RESULTS

FCC Rules	Description of Test	Results
§15.107	AC Line Conducted Emissions	Compliance
§15.109	Radiated Spurious Emissions	Compliance

## FCC §15.107 – AC LINE CONDUCTED EMISSIONS

### Applicable Standard

According to FCC §15.107

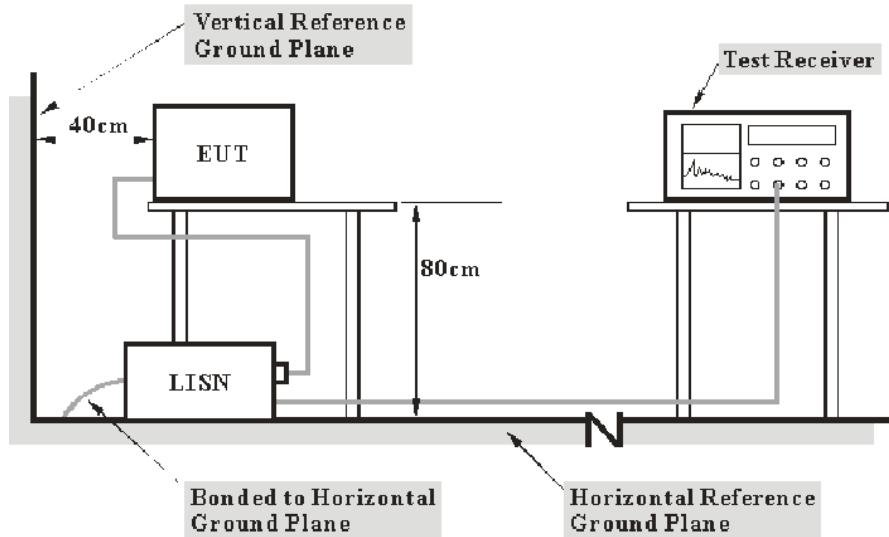
### Measurement Uncertainty

Input quantities to be considered for conducted disturbance measurements maybe receiver reading, attenuation of the connection between AMN/ISN and receiver, AMN/ISN voltage division factor, AMN/ISN VDF frequency interpolation and receiver related input quantities, etc.

Based on CISPR 16-4-2:2011, the expended combined standard uncertainty of conducted disturbance test at Bay Area Compliance Laboratories Corp. (Shenzhen) is shown as below. And the uncertainty will not be taken into consideration for the test data recorded in the report

Port	Measurement uncertainty
AC Mains	3.26 dB (k=2, 95% level of confidence)
CAT 3	3.70 dB (k=2, 95% level of confidence)
CAT 5	3.86 dB (k=2, 95% level of confidence)
CAT 6	4.64 dB (k=2, 95% level of confidence)

### EUT Setup



Note: 1. Support units were connected to second LISN.  
 2. Both of LISNs (AMN) 80 cm from EUT and at the least 80 cm from other units and other metal planes support units.

The measurement procedure of EUT setup is according with per ANSI C63.4-2009. The related limit was specified in FCC Part 15.107 Class B.

The spacing between the peripherals was 10 cm.

The host PC was connected to a 120 VAC/60 Hz power source.

## EMI Test Receiver Setup

The EMI test receiver was set to investigate the spectrum from 150 kHz to 30 MHz.

During the conducted emission test, the EMI test receiver was set with the following configurations:

Frequency Range	IF B/W
150 kHz – 30 MHz	9 kHz

## Test Procedure

During the conducted emission test, the host PC was connected to the first LISN and the other relevant equipments were connected to the second LISN.

Maximizing procedure was performed on the six (6) highest emissions of the EUT.

All data was recorded in the Quasi-peak and average detection mode.

## Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
Rohde & Schwarz	EMI Test Receiver	ESCS30	100176	2014-06-03	2015-06-03
Rohde & Schwarz	LISN	ENV216	3560.6650.12-101613-Yb	2014-06-09	2015-06-09
Rohde & Schwarz	LISN	ESH2-Z5	892107/021	2014-06-09	2015-06-09
Rohde & Schwarz	Transient Limitor	ESH3Z2	DE25985	2014-05-14	2015-05-14
Rohde & Schwarz	CE Test software	EMC 32	V8.53	--	--

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Shenzhen) attests that all calibrations have been performed in accordance to requirements that traceable to National Primary Standards and International System of Units (SI).

## Corrected Factor & Margin Calculation

The Corrected factor is calculated by adding LISN/ISN VDF (Voltage Division Factor), Cable Loss and Transient Limiter Attenuation. The basic equation is as follows:

$$\text{Correction Factor} = \text{LISN VDF} + \text{Cable Loss} + \text{Transient Limiter Attenuation}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

## Test Results Summary

According to the recorded data in following table, the EUT complied with the FCC Part 15.107, with the worst margin reading of:

**4.0 dB at 18.854610 MHz in the Line conducted mode**

Refer to CISPR16-4-2:2011 and CISPR 16-4-1:2009, the measured level is in compliance with the limit if

$$L_m + U_{(Lm)} \leq L_{lim} + U_{cisp}$$

in BACL.,  $U_{(Lm)}$  is less than  $U_{cisp}$ , if  $L_m$  is less than  $L_{lim}$ , it implies that the EUT complies with the limit.

## Test Data

### Environmental Conditions

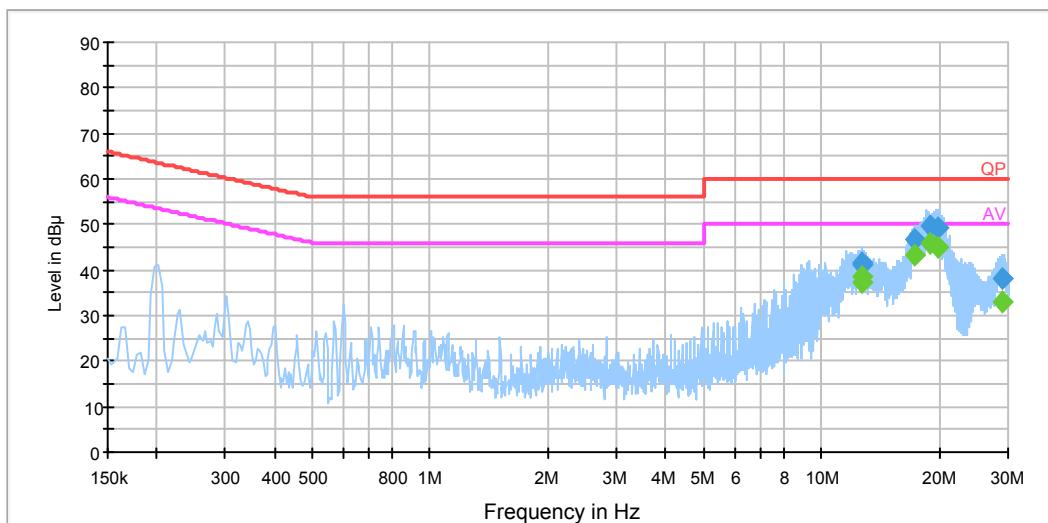
<b>Temperature:</b>	22 °C
<b>Relative Humidity:</b>	50 %
<b>ATM Pressure:</b>	101.0 kPa

*The testing was performed by Simon Wang on 2015-01-19*

*EUT Operation Mode: Downloading*

**AC 120V/60 Hz, Line**

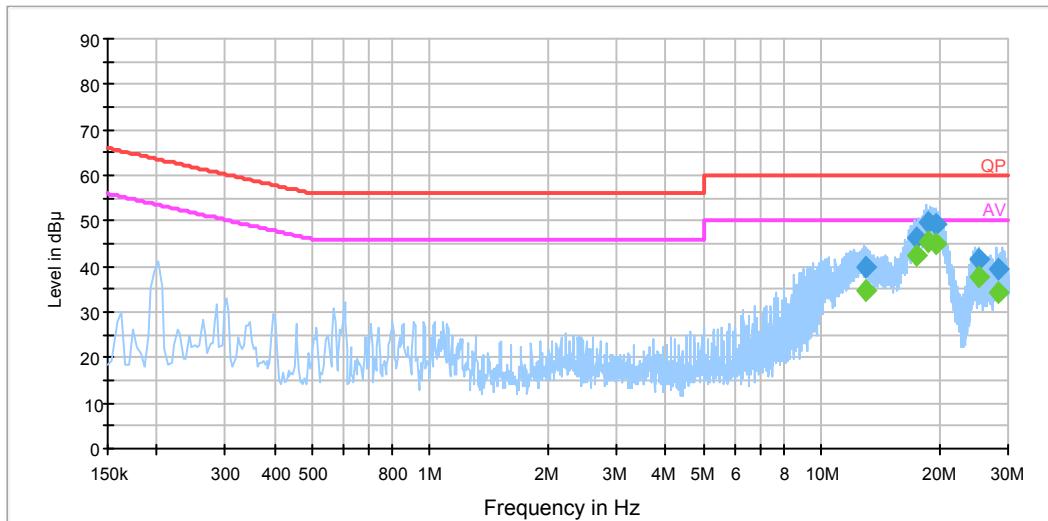
EMI Auto Test L



Frequency (MHz)	Corrected Amplitude (dB $\mu$ V)	Correction Factor (dB)	Limit (dB $\mu$ V)	Margin (dB)	Detector (PK/Ave./QP)
12.665130	41.2	19.7	60.0	18.8	QP
12.665130	37.4	19.7	50.0	12.6	Ave.
12.747710	41.7	19.7	60.0	18.3	QP
12.747710	38.6	19.7	50.0	11.4	Ave.
17.367770	46.9	19.7	60.0	13.1	QP
17.367770	43.3	19.7	50.0	6.7	Ave.
18.854610	49.8	19.7	60.0	10.2	QP
18.854610	46.0	19.7	50.0	4.0	Ave.
19.819950	49.5	19.7	60.0	10.5	QP
19.819950	45.2	19.7	50.0	4.8	Ave.
29.108710	38.0	19.9	60.0	22.0	QP
29.108710	32.9	19.9	50.0	17.1	Ave.

## AC 120V/60 Hz, Neutral

## EMI Auto Test N



Frequency (MHz)	Corrected Amplitude (dB $\mu$ V)	Correction Factor (dB)	Limit (dB $\mu$ V)	Margin (dB)	Detector (PK/Ave./QP)
12.976770	39.8	19.7	60.0	20.2	QP
12.976770	34.6	19.7	50.0	15.4	Ave.
17.503130	46.5	19.7	60.0	13.5	QP
17.503130	42.4	19.7	50.0	7.6	Ave.
18.704170	49.8	19.7	60.0	10.2	QP
18.704170	45.6	19.7	50.0	4.4	Ave.
19.615070	49.4	19.6	60.0	10.6	QP
19.615070	44.9	19.6	50.0	5.1	Ave.
25.268450	41.4	19.8	60.0	18.6	QP
25.268450	37.6	19.8	50.0	12.4	Ave.
28.476650	39.4	19.8	60.0	20.6	QP
28.476650	34.2	19.8	50.0	15.8	Ave.

**Note:**

- 1) Correction Factor =LISN VDF (Voltage Division Factor) + Cable Loss + Transient Limiter Attenuation  
The corrected factor has been input into the transducer of the test software.
- 2) Corrected Amplitude = Reading + Correction Factor
- 3) Margin = Limit – Corrected Amplitude

## FCC §15.109 - RADIATED SPURIOUS EMISSIONS

### Applicable Standard

FCC §15.109

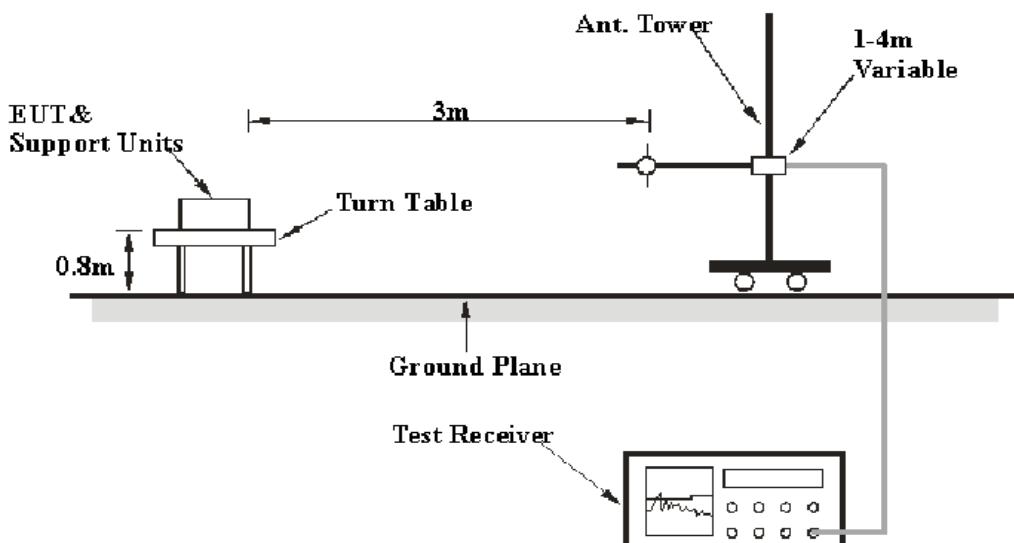
### Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on CISPR 16-4-2:2011, the expended combined standard uncertainty of radiation emissions at Bay Area Compliance Laboratories Corp. (Shenzhen) is shown in below table. And the uncertainty will not be taken into consideration for the test data recorded in the report

Frequency	Polarity	Measurement uncertainty
30 MHz~200 MHz	Horizontal	4.62 dB (k=2, 95% level of confidence)
	Vertical	4.54 dB (k=2, 95% level of confidence)
200 MHz~1 GHz	Horizontal	4.84 dB (k=2, 95% level of confidence)
	Vertical	5.91 dB (k=2, 95% level of confidence)
1 GHz~6 GHz	Horizontal/Vertical	4.68 dB (k=2, 95% level of confidence)
Above 6 GHz	Horizontal/Vertical	4.92 dB (k=2, 95% level of confidence)

### EUT Setup



The radiated emission tests were performed in the 3 meters chamber test site, using the setup accordance with the ANSI C63.4-2009. The specification used was the FCC Part 15.109 Class B limits.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

The host PC was connected to a 120 VAC/60 Hz power source.

### EMI Test Receiver Setup

The system was investigated from 30 MHz to 2.0 GHz.

During the radiated emission test, the EMI test receiver was set with the following configurations:

Frequency Range	RBW	Video B/W	IF B/W	Detector
30 MHz – 1000 MHz	100 kHz	300 kHz	120 kHz	QP
Above 1 GHz	1MHz	3 MHz	/	PK
	1MHz	10 Hz	/	Ave.

### Test Procedure

Maximizing procedure was performed on the highest emissions to ensure that the EUT complied with all installation combinations.

All data was recorded in the Quasi-peak detector mode from 30 MHz to 1 GHz and PK and average detector modes for frequencies above 1 GHz.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
HP	Amplifier	8447E	1937A01046	2014-05-06	2015-05-06
Rohde & Schwarz	EMI Test Receiver	ESCI	101120	2014-11-03	2015-11-03
Sunol Sciences	Broadband Antenna	JB3	A111513	2014-06-18	2017-06-17
A.H. System	Horn Antenna	SAS-200/571	135	2012-02-11	2015-02-10
Rohde & Schwarz	Signal Analyzer	FSIQ26	837405/023	2014-08-22	2015-08-22
Mini	Pre-amplifier	ZVA-183-S+	5969001149	2014-04-23	2015-04-23
TDK	Chamber	Chamber A	2#	2012-10-15	2015-10-15
TDK	Chamber	Chamber B	1#	2012-07-23	2015-07-22
R&S	Auto test Software	EMC32	V9.10	-	-

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Shenzhen) attests that all calibrations have been performed in accordance to requirements that traceable to National Primary Standards and International System of Units (SI).

## Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Loss, and subtracting the Amplifier Gain from the Meter Reading. The basic equation is as follows:

$$\text{Corrected Amplitude} = \text{Meter Reading} + \text{Antenna Factor} + \text{Cable Loss} - \text{Amplifier Gain}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

## Test Results Summary

According to the data in the following table, the EUT complied with the FCC §15.109 Class B, with the worst margin reading of:

**3.37 dB at 880.271875 MHz** in the **Horizontal** polarization mode

Refer to CISPR16-4-2:2011 and CISPR 16-4-1:2009, the measured level is in compliance with the limit if

$$L_m + U_{(L_m)} \leq L_{\lim} + U_{\text{cisp}}$$

In BACL,  $U_{(L_m)}$  is less than  $U_{\text{cisp}}$ , if  $L_m$  is less than  $L_{\lim}$ , it implies that the EUT complies with the limit.

## Test Data

### Environmental Conditions

<b>Temperature:</b>	22 °C
<b>Relative Humidity:</b>	50 %
<b>ATM Pressure:</b>	101.0 kPa

*The testing was performed by Simon Wang on 2015-01-19*

*EUT Operation Mode: Downloading*

**30 MHz – 2.0 GHz**

Frequency (MHz)	Receiver		Turntable Degree	Rx Antenna		Corrected Factor (dB/m)	Corrected Amplitude (dB $\mu$ V/m)	FCC Part 15B	
	Reading (dB $\mu$ V)	Detector (PK/QP/Ave.)		Height (m)	Polar (H/V)			Limit (dB $\mu$ V/m)	Margin (dB)
30.389625	31.30	QP	307	1.0	V	-6.20	25.10	40.00	14.90
174.836125	36.29	QP	316	1.1	V	-14.90	21.39	43.50	22.11
239.968625	27.03	QP	311	1.1	V	-14.80	12.23	46.00	33.74
284.864750	45.72	QP	197	1.2	V	-12.60	33.12	46.00	12.88
479.852500	44.51	QP	0	1.2	V	-8.60	35.91	46.00	10.08
880.271875	45.83	QP	209	1.9	H	-3.20	42.63	46.00	3.37
1163.20000	56.90	PK	214	2.0	H	-0.58	56.32	74.00	17.68
1163.20000	30.11	Ave.	214	2.0	H	-0.58	29.53	54.00	24.47
1610.50000	44.37	PK	73	1.2	V	1.70	46.07	74.00	27.93
1610.50000	26.25	Ave.	73	1.2	V	1.70	27.95	54.00	26.05

Note:

- 1) Correction Factor=Antenna factor (RX) + cable loss – amplifier factor
- 2) Corrected Amplitude = Correction Factor + Reading
- 3) Margin = Limit - Corrected Amplitude

## PRODUCT SIMILARITY DECLARATION LETTER



International Limited

Sourcing the best for the future

Complex International Limited

Unit902-904,9th Floor,Tower B,Hung Hom Commercial Centre,37,Ma Tau Wai  
Road,Hung Hom,Kowloon, Hong Kong

Tel: 86-755-29081966

2015/01/20

### Product Similarity Declaration

To Whom It May Concern,

We, Complex International Limited, hereby declare that our 2G feature phone, Model Number: JV X57 and JFP 75 are electrically identical with the model number JV X57 that was tested by BACL. They are just different in model numbers and Appearance colors.

Please contact me if you have any question.

Signature:

Hugo Zhai

Project Manager

For and on behalf of  
COMPLEX INTERNATIONAL LIMITED  
浩威国际有限公司

A handwritten signature in black ink, appearing to read 'Hugo'.

\*\*\*\*\* END OF REPORT \*\*\*\*\*